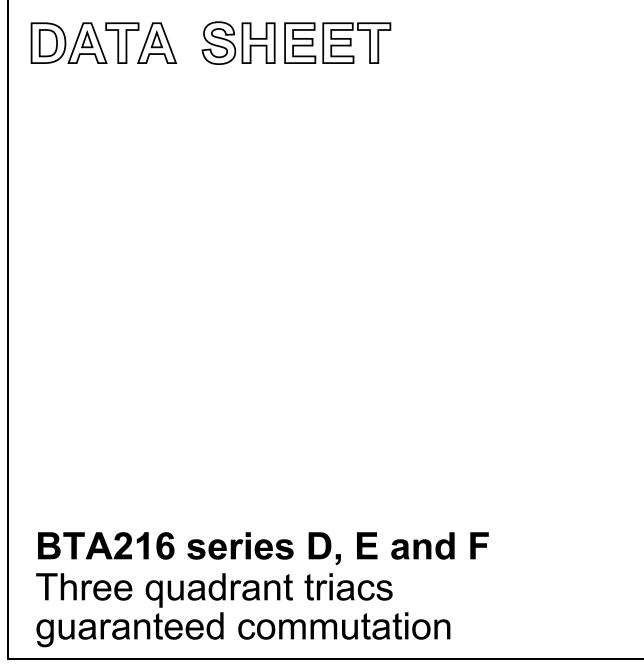
DISCRETE SEMICONDUCTORS



Product specification

April 2002



MAX.

600D

600E

600F

600

16

140

UNIT

٧

A

А

## Three quadrant triacs guaranteed commutation

# BTA216 series D, E and F

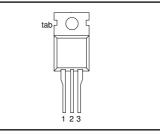
## **GENERAL DESCRIPTION**

Passivated guaranteed commutation triacs in a plastic envelope intended for use in motor control circuits or with other highly inductive These devices balance loads. the requirements of commutation performance and gate sensitivity. The "sensitive gate" E series and "logic level" D series are intended for interfacing with low power drivers, including micro controllers.

## **PINNING - TO220AB**

### PIN DESCRIPTION

### 1 main terminal 1 2 main terminal 2 3 gate main terminal 2 tab



QUICK REFERENCE DATA

current

PARAMETER

Repetitive peak off-state

Non-repetitive peak on-state

voltages RMS on-state current

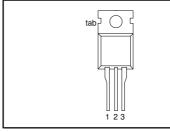


BTA216-

**BTA216-**

**BTA216-**

SYMBOL



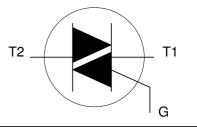
**PIN CONFIGURATION** 

SYMBOL

V<sub>DRM</sub>

T(RMS)

I<sub>TSM</sub>



## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DRM</sub>	Repetitive peak off-state voltages		-	600 <sup>1</sup>	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>mb</sub> ≤ 99 °C	-	16	А
	Non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge t = 20 ms t = 16.7 ms	- -	140 150	A
l <sup>2</sup> t dI <sub>T</sub> /dt	I <sup>2</sup> t for fusing Repetitive rate of rise of on-state current after triggering		-	98 100	A²s A/μs
$\begin{matrix} I_{GM} \\ P_{GM} \\ P_{G(AV)} \end{matrix}$	Peak gate current Peak gate power Average gate power	over any 20 ms	- - -	2 5 0.5	A W W
T <sub>stg</sub> T <sub>j</sub>	Storage temperature Operating junction temperature	period	-40 -	150 125	°C °C

<sup>1</sup> Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/µs.

# Three quadrant triacs guaranteed commutation

# BTA216 series D, E and F

## THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R <sub>th j-mb</sub> R <sub>th j-a</sub>	Thermal resistance junction to mounting base Thermal resistance junction to ambient	full cycle half cycle in free air	-	- - 60	1.2 1.7 -	K/W K/W K/W

## STATIC CHARACTERISTICS

 $T_j = 25$  °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.		UNIT	
		BTA216-		D	E	F	
I <sub>GT</sub>	Gate trigger current <sup>2</sup>	$V_{\rm D} = 12 \text{ V}; I_{\rm T} = 0.1 \text{ A}$					
		T2+ G+	-	5 5 5	10	25	mA
		T2+ G-	-	5	10	25	mA
Ι.		T2- G-	-	5	10	25	mA
I IL	Latching current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$		4.5	05	00	
		T2+G+	-	15	25	30	mA
		T2+ G-   T2- G-	-	25 25	30	40 40	mA mA
		12- G-	-	25	30	40	mA
I <sub>H</sub>	Holding current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$	-	15	25	30	mA
			D, E, F				
V <sub>T</sub>	On-state voltage	I <sub>⊤</sub> = 20 A	-		1.5		V
V <sub>T</sub> V <sub>GT</sub>	Gate trigger voltage	$\dot{V}_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$	-		1.5		V
		$V_{\rm D} = 400 \text{ V}; I_{\rm T} = 0.1 \text{ A};$	0.25		-		V
,	Off-state leakage current	$T_{i} = 125 °C$			0.5		mA
I <sub>D</sub>	On-State leakage cullent	$V_D = V_{DRM(max)}; T_j = 125 °C$	-		0.5		IIIA

## **DYNAMIC CHARACTERISTICS**

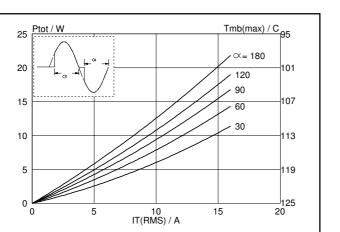
 $T_i = 25$  °C unless otherwise stated

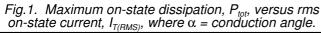
SYMBOL	PARAMETER	CONDITIONS	MIN.		MAX.	UNIT	
		BTA216-	D	E	F		
dV <sub>D</sub> /dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)};$ $T_j = 110 °C;$ exponential waveform; gate open circuit	30	60	70	-	V/µs
dl <sub>com</sub> /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; \text{T}_{j} = 125 ^{\circ}\text{C};$ $I_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 10V/\mu\text{s}; \text{ gate}$ open circuit	2.5	6.2	18	-	A/ms
dl <sub>com</sub> /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; \text{ T}_{j} = 125 \text{ °C};$ $I_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 0.1 \text{ V}/\mu\text{s};$ gate open circuit	12	20	50	-	A/ms

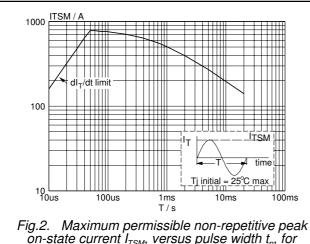
**<sup>2</sup>** Device does not trigger in the T2-, G+ quadrant.

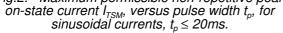
BTA216 series D, E and F

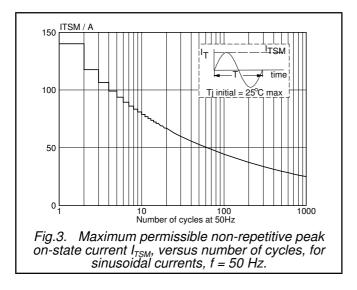
# Three quadrant triacs guaranteed commutation

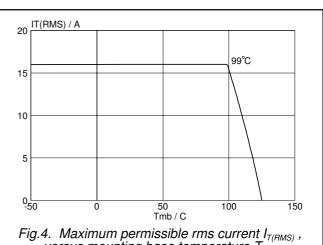


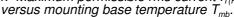


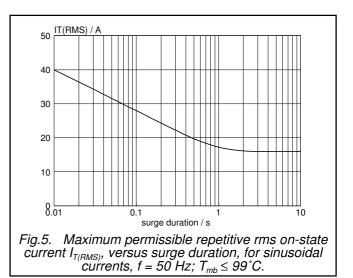


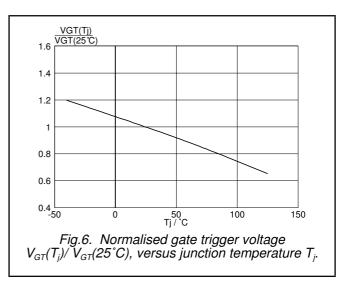












BTA216 series D, E and F

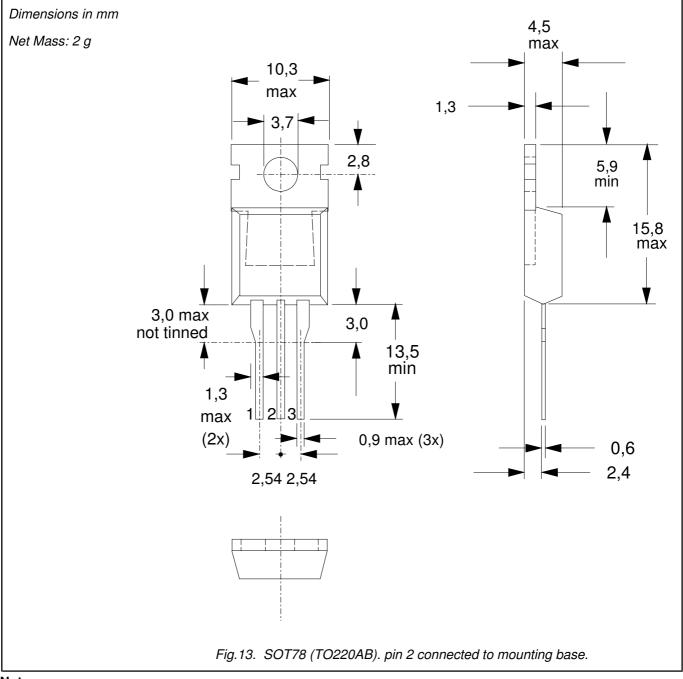
# Three quadrant triacs guaranteed commutation

#### IT / A IGT(Tj) IGT(25℃) 50 Tj = 125 C Tj = 25 C 3 — T2+ G+ — T2+ Gtyp ma - T2- G-40 2.5 Vo = 1.195 V Rs = 0.018 Ohms 2 30 1.5 20 1 10 0.5 0 L 0 0 1.5 VT / V 150 0.5 2 2.5 3 -50 0 тј/℃ 100 1 Fig.7. Normalised gate trigger current $I_{GT}(T_j)/I_{GT}(25^{\circ}C)$ , versus junction temperature $T_{j}$ . Fig.10. Typical and maximum on-state characteristic. 10 \_\_\_\_\_(K/W) IL(Tj) IL(25°C) 3 25 1 bidirectional 2 0.1 1.5 1 0.01 0.5 0.001 – 10us 0 -50 0.1ms 10ms 0.1s 1s 10s 50 Tj /℃ 100 1ms 0 150 tp/s Fig.11. Transient thermal impedance $Z_{th j-mb}$ , versus Fig.8. Normalised latching current $I_L(T_i)/I_L(25^{\circ}C)$ , versus junction temperature $T_{i}$ pulse width $t_{\rm p}$ . dlcom/dt (A/ms) IH(Tj) 100 3 IH(25°C F TYPE E TYPE D TYPE 2.5 2 10 1.5 1 0.5 1 0 -50 50 Tj /℃ 20 40 60 100 120 140 100 150 80 Tj/°C 0 Fig.9. Normalised holding current $I_H(T_i)/I_H(25^{\circ}C)$ , versus junction temperature $T_j$ . Fig.12. Minimum, critical rate of change of commutating current $dI_{com}/dt$ versus junction temperature, $dV_{com}/dt = 10V/\mu s$ .

# Three quadrant triacs guaranteed commutation

# BTA216 series D, E and F

## **MECHANICAL DATA**



Notes 1. Refer to mounting instructions for SOT78 (TO220) envelopes. 2. Epoxy meets UL94 V0 at 1/8".

## Legal information

## DATA SHEET STATUS

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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